

<b>Notice of References Cited</b>		Application/Control No. 09/857,652	Applicant(s)/Patent Under Reexamination NONAKA ET AL.	
		Examiner Shean C Wu	Art Unit 1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5413735	05-1995	Yamashita et al.	252/299.61
B	US-6368679 B1	04-2002	Schmidt et al.	428/1.1
C	US-6482479 B1	11-2002	Dubal et al.	428/1.1
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign